

# Statement of Conformity

## Best Laboratory Co., Ltd.

No. 336, Ba Lian RD., Sec. 1, Hsi Chih City, Taipei Hsien, Taiwan, R.O.C.

Telephone: 886-2-2646-2899 Facsimile: 886-2-2646-2870

## *EMC Certificate*

**Applicant** : Advantech Co., Ltd.

**Address** : Fl.4, No. 108-3, Ming-Chuan Road,  
Shing-Tien City, Taipei, Taiwan, R.O.C.

**Equipment** : Half size CPU card support PIII level CPU W/LAN, USB x 2,  
COM x 2, VGA, LPT, PS/2 Keyboard & Mouse

**Model** : PCI-6871

Has fully complied with the requirements set out in the council directive on the approximation of the law of the members states relating to Electromagnetic Compatibility Directive (89/336/EEC). For the evaluation regarding EMC, the following standards were applied:

EMI: EN 50081-1:1993 -> EN 55022:1999, EN 61000-3-2:2000, EN 61000-3-3:1995

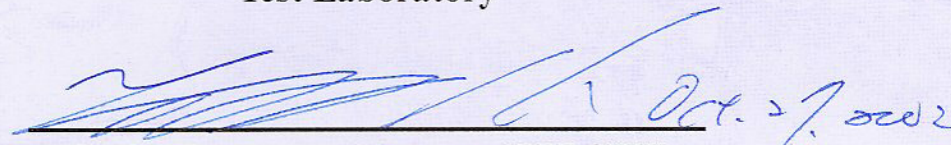
EMS: EN 55024:1998 -> EN 61000-4-2:1998, EN 61000-4-3:1998,  
EN 61000-4-4:1995, EN 61000-4-5:1995,  
EN 61000-4-6:1996, EN 61000-4-8:1993,  
EN 61000-4-11:1994,

**The date of the measurement: Oct. 25, 2002**

**The date of the certification signed: Oct. 27, 2002**

**The number of EMC Certificate: CER-A01-CE-912**

**Test Laboratory**



**Quality Department Manager: JEFF CHIU**



This verification is based on a single evaluation of one sample of above-mentioned products. It does not imply any assessment of the whole production and does not permit the use of the logo of the test laboratory.

# EMC TEST REPORT

**Applicant : Advantech Co., Ltd.**

**Equipment : Half size CPU card support PIII level CPU  
W/LAN, USB x 2, COM x 2, VGA, LPT,  
PS/2 Keyboard & Mouse**

**Model : PCI-6871**



# Test Report Certification

## Best Laboratory Co., Ltd.

No. 336, Ba Lian Rd., Sec. 1, Hsi Chih City, Taipei Hsien, Taiwan, R.O.C.

Tel: 886-2-2646-2899 Fax: 886-2-2646-2870

Applicant : Advantech Co., Ltd.

Address : Fl.4, No. 108-3, Ming-Chuan Road,  
Shing-Tien City, Taipei, Taiwan, R.O.C.

Equipment : Half size CPU card support PIII level CPU W/LAN, USB x 2,  
COM x 2, VGA, LPT, PS/2 Keyboard & Mouse

Model : PCI-6871

Device's Class : Class B Device

Measurement Standard : EN 50081-1/1992, EN 55024/1998

Measurement Procedure : EN 55022/1998, EN 61000-3-2/2000, EN 61000-3-3/1995  
EN 61000-4-2/1998, EN 61000-4-3/1998, EN 61000-4-4/1995,  
EN 61000-4-5/1995, EN 61000-4-6/1996, EN 61000-4-8/1993  
EN 61000-4-11/1994

Operating Voltage : By PC

Test Result : **Compliance** (Detail showed in the test report)

Sample Received : Oct. 23, 2002

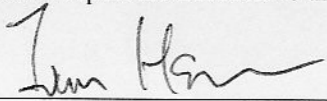
Test Date : Oct. 25, 2002

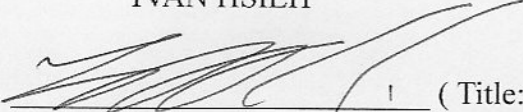
Report Number : RE-A01-CE-912

Test Firm : No. 336, Ba Lian Rd., Sec. 1,  
Hsi Chih City, Taipei Hsien, Taiwan, R.O.C.

### Remark:

- (1) The test report is only relating to the sample tested
- (2) The test report shall not be reproduced except in full, without the written approval of Best Laboratory Co., Ltd.
- (3) The test result of this report are traceable to the national or international standards.

Prepared :   
IVAN HSIEH

Approved :  ( Title: Quality Department Manager )  
JEFF CHIU

Date Issued : Oct. 27, 2002

# Contain

## 1 General Information

1.1	EUT Description.....	4
1.2	Test System Detail.....	5
1.3	Tested Configuration.....	7
1.4	EUT Exercise Software.....	8
1.5	Test Performed.....	8

## 2 Conducted Emission Measurement

2.1	Test Equipment List.....	9
2.2	Test Set-Up.....	9
2.3	Limit .....	9
2.4	Test Procedure.....	10
2.5	Test Specification.....	10
2.6	Test Result.....	10

## 3 Radiated Emission Measurement

3.1	Test Equipment List.....	11
3.2	Test Set-Up.....	11
3.3	Limit.....	12
3.4	Test Procedure.....	12
3.5	Test Specification.....	12
3.6	Test Result.....	12

## 4 Power Harmonic and Voltage Fluctuation

4.1	Power Harmonic and voltage Fluctuation test Equipment List.....	13
4.2	Test Set-Up.....	13
4.3	Limit.....	13
4.4	Test Procedure.....	14
4.5	Test Specification.....	14
4.6	Test Result.....	14

## 5 Electrostatic Discharge (ESD)

5.1	Test Equipment List.....	15
5.2	Test Set-Up.....	15
5.3	Test Level.....	15
5.4	Test Procedure.....	16
5.5	Test Specification.....	16
5.6	Test Result.....	16

## 6 Radiated Susceptibility (RS)

6.1	Test Equipment List.....	17
6.2	Test Set-Up.....	17
6.3	Test Level.....	17
6.4	Test Procedure.....	18
6.5	Test Specification.....	18
6.6	Test Result.....	18

**7 Electrical Fast Transient/Burst**

7.1 Test Equipment List.....	19
7.2 Test Set-Up.....	19
7.3 Test Level.....	19
7.4 Test Procedure.....	20
7.5 Test Specification.....	20
7.6 Test Result.....	20

**8 Surge**

8.1 Test Equipment List.....	21
8.2 Test Set-Up.....	21
8.3 Test Level.....	21
8.4 Test Procedure.....	22
8.5 Test Specification.....	22
8.6 Test Result.....	22

**9 Conducted Susceptibility**

9.1 Test Equipment List.....	23
9.2 Test Set-Up.....	23
9.3 Test Level.....	24
9.4 Test Procedure.....	24
9.5 Test Specification.....	24
9.6 Test Result.....	24

**10 Power Frequency Magnetic Field**

10.1 Test Equipment List.....	25
10.2 Test Set-Up.....	25
10.3 Test Level.....	25
10.4 Test Procedure.....	26
10.5 Test Specification.....	26
10.6 Test Result.....	26

**11 Voltage DIPS and Interruption Measurement**

11.1 Test Equipment List.....	27
11.2 Test Set-Up.....	27
11.3 Test Level.....	27
11.4 Test Procedure.....	28
11.5 Test Specification.....	28
11.6 Test Result.....	28

**12 Modification List****13 Appendix**

Appendix A: Summary of Test Result.....	31
Appendix B: The Photograph of measurement.....	44
Appendix C: The Detail Photograph of EUT.....	51

# 1. General Information

## 1.1 EUT Description

Applicant : Advantech Co., Ltd.

Address : Fl.4, No. 108-3, Ming-Chuan Road,  
Shing-Tien City, Taipei, Taiwan, R.O.C.

Equipment : Half size CPU card support PIII level CPU W/LAN, USB x 2,  
COM x 2, VGA, LPT, PS/2 Keyboard & Mouse

Model : PCI-6871

Device's Class : Class B Device

Operation Voltage : By PC

Output Ports :

Monitor Port : Connected with one monitor which data cable is 1.8 meters long, shielded, with ferrite bead.

Serial Port : Connected with one external modem, via one RS-232 cable which data cable is 180cm long, non-shielded, no ferrite bead.

LAN#1 Port : Connected with one RJ-45 cable, 25 meters long, non-shielded, no ferrite bead, to the far-end HUB.

PS/2 Keyboard Port : Connected with one PS/2 keyboard which length is 120 cm long, non-shielded, no ferrite bead.

IDE Connector : Connected with one floppy and HDD, via one rainbow cable which length is 30 cm long, shielded, no ferrite bead.

USB Connector : Connected with two USB connector installed on case, via one data cable, 30 cm long, non-shielded, no ferrite bead.

Parallel Connector : Connected with one 25-pin D-Sub connector screwed on the chassis, via one rainbow cable, 30 cm long, non-shielded, no ferrite bead.

Serial Connector : Connected with one 9-pin D-Sub connector screwed on the chassis, via one rainbow cable, 30 cm long, non-shielded, no ferrite bead.

RAM Socket : Directly plugged in one RAM.

## 1.2 Test System Detail

**Monitor : HITACHI**

Model No. : CM771U  
Serial No. : V0E001074  
FCC ID : DoC Approval  
BSMI : 3882A707  
Power Type : 100-240VAC, 50/60Hz, 1.5A, Switching  
Power Cord : 180cm long, non-shielded, no ferrite bead  
Data Cable : 120cm long, shielded, with ferrite bead  
Backshell : Metal  
Connected Port : VGA Port

**Keyboard : Logitec**

Model No. : SK-720  
Serial No. : N/A  
FCC ID : GYUR49SK  
BSMI : 3872A806  
Power Type : By PC  
Data Cable : 180cm long, shielded, no ferrite bead  
Backshell : Metal  
Connected Port : PS/2 Keyboard Port

**USB Mouse : Logitech**

Model No. : M-BB48  
Serial No. : LZE92250126; LZE93050066  
FCC ID : DoC Approval  
BSMI : 4872A221  
Power Type : By PC  
Data Cable : 120cm long, non-shielded, no ferrite bead

**Modem : ACER**

Model No. : AME-AX00  
Serial No. : 10100976  
FCC ID : DoC Approval  
BSMI : 3892B064  
Power Type : 230VAC, 50Hz / 9VAC, 1A  
Power Core : 1.9meters long, non-shielded, no ferrite bead  
Data Cable : RS-232, shielded, 1.2meters long, no ferrite bead  
RJ11C x 1.8meters long, non-shielded, no ferrite bead  
Backshell : Metal  
Connected Port : Serial Port.

**Case : Advantech**

Model No. : IPC-610MB-00  
Serial No. : CDA0050753  
Power Cord : 180cm long, non-shielded, no ferrite bead.

**Back Plane : Advantech**

Model No. : PCA-6114P4  
Serial No. : 99108480

**CPU : Cyrix**

Model No. : Cyrix III 400

**Hard disk driver : Seagate**

Model No. : ST34342A  
Serial No. : VGB52216  
FCC ID : DoC Approval  
Power Type : Powered by PC  
Power Cord : 26cm long, non-shielded, no ferrite bead.

**Floppy disk driver : Teac**

Model No. : FD-235HF  
Serial No. : L485713  
FCC ID : DoC Approval  
BSMI : 3892A889  
Power Type : Powered by PC  
Power Cord : 26cm long, non-shielded, no ferrite bead.

**RAM : Advantech**

Model No. : PCM-220 128MHz  
Serial No. : 1906022002

**Power : Bestec**

Model No. : BPS-2504-4TU  
Serial No. : 97021145  
FCC ID : DoC Approval  
Power Type : 115/230VAC, 60/50Hz, 6A/3.0A, Switching  
Power Cord : 40cm long, non-shielded, no ferrite bead.

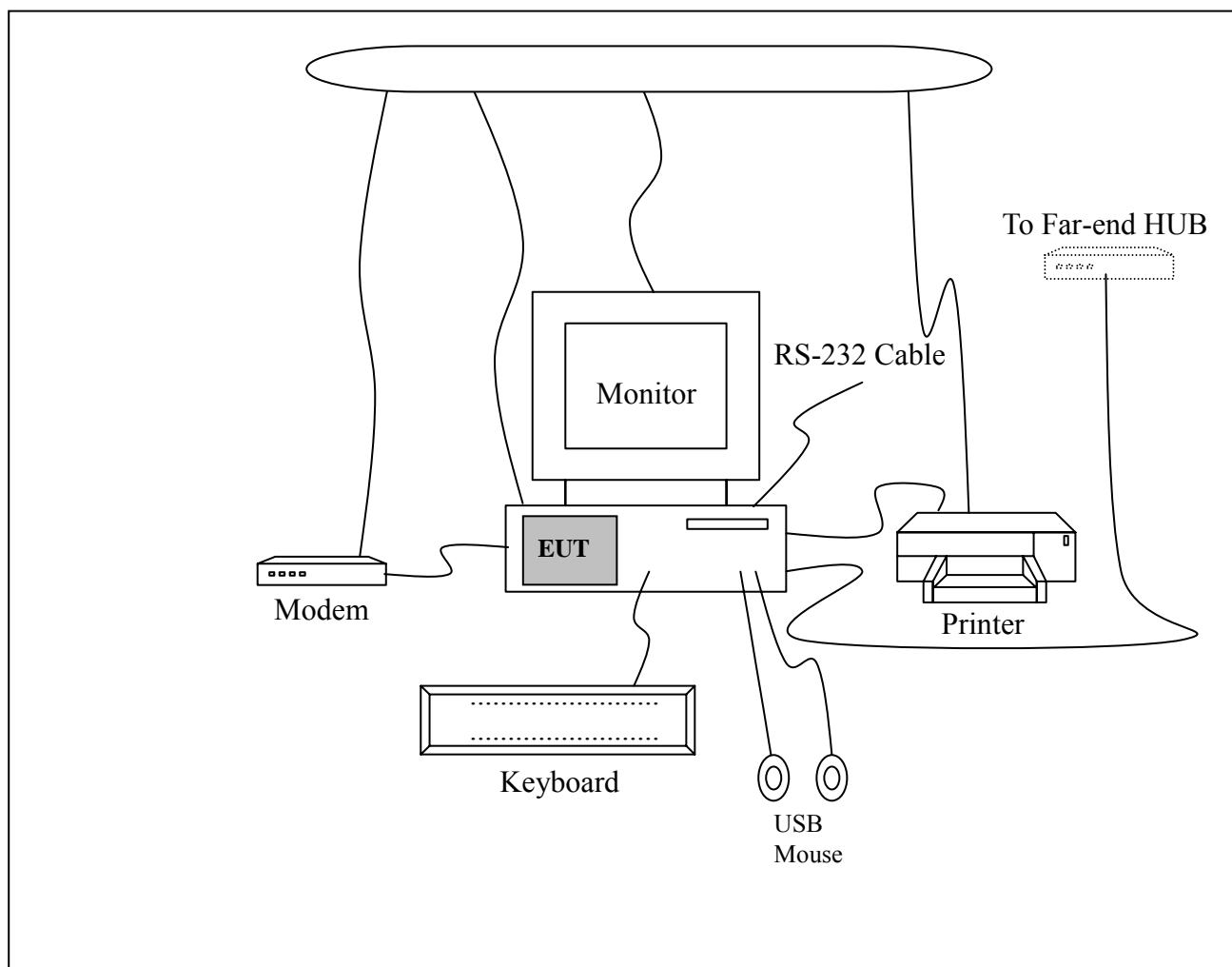


### 1.3 EUT Configuration

- (1) The monitor port of EUT is connected with one monitor.
- (2) The serial port of EUT is connected with an external modem.
- (3) The LAN port of EUT is connected with the HUB located in far-end.
- (4) The PS/2 keyboard port of EUT is connected with one PS/2 keyboard.
- (5) The IDE connector of EUT is connected with the floppy and HDD.
- (6) The USB connector of EUT is connected with two USB connector screwed on the chassis, via one data cable.
- (7) The parallel connector of EUT is connected with one 25-pin D-Sub connector screwed on the chassis, via one rainbow cable.
- (8) The serial connector of EUT is connected with one 9-pin D-Sub connector screwed on the chassis, via one rainbow cable.
- (9) The RAM socket of EUT is plugged in one RAM.

(\*\*PS: Please refers to the Photograph\*\*)

### Drawing of Configuration



## 1.4 EUT Exercise Software

The testing software is provided by the applicant.

It is designed to exercise the EUT in a manner similar to a typical use. The testing software will link two LAN cards to transmit data, via two RJ-45 jacks. The software will send an " H " pattern to the monitor and the " H " pattern will be shown on the monitor. The software will also send an " H " pattern to the printer and the " H " pattern will be printer out at the printer. The software will also send the data to the modem and the modem will response to the EUT. The HDD will continuously working sequence in the " Write-Read-Delete " mode. At the same time, the mouse and keyboard will be in continuously self-test mode and responded to the EUT. The software will enable all functions of EUT.

## 1.5 Test Performed

Conducted emissions were invested over the frequency range from 0.15MHz to 30MHz using a receiver which bandwidth is set at 9KHz.

Radiated emissions were invested over the frequency range from 30MHz to 1000MHz using a receiver which bandwidth is set at 120KHz. Radiated measurement was performed at distance that from an antenna to EUT is 10 meters.

The testing result of pretest was shown out that the "Transmitting/Receiving" mode is worse than the " Standby " mode. So, the final measurement was made on the "Transmitting/Receiving" mode.

Because of the specification of the LAN port of EUT, there are two testing modes when the measurements were taken: 10MHz and 100MHz.

There is one video resolution testing mode when the tests and the measurements was performed: "800 X 600".

The testing result of pretest was shown out that the "LAN=100MHz" mode is worse than other modes. So, the final measurement was made on the "LAN=100MHz" mode.

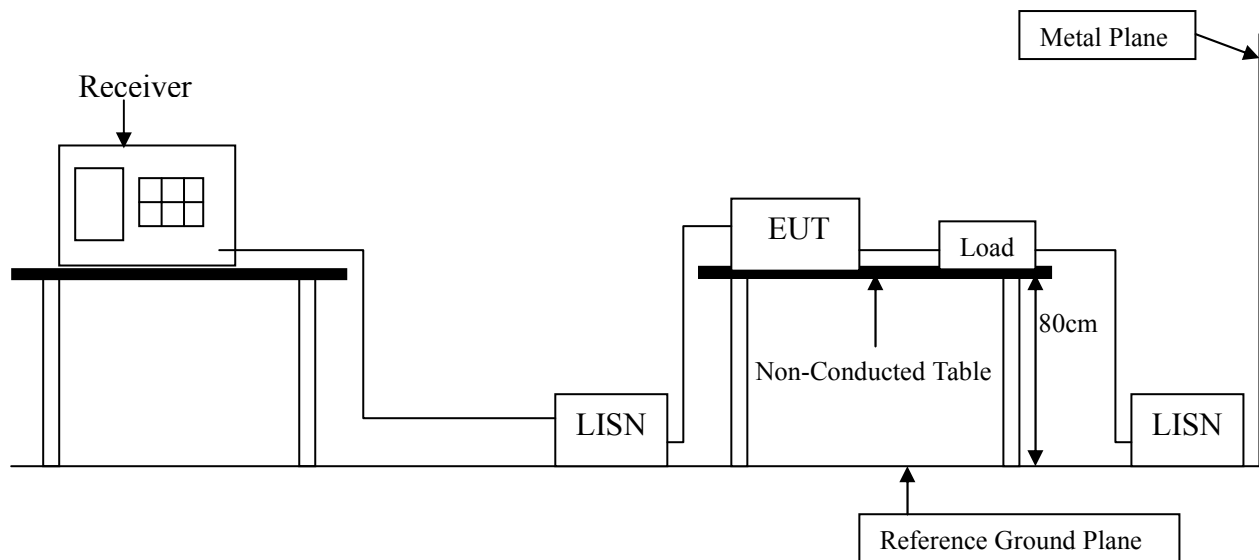
## 2 Conducted Emission Measurement

### 2.1 Test Equipment

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	LISN (EUT)	Rolf Heine	NNB-2/16Z	99084	May 14, 2002
2.	LISN (AXE)	Rolf Heine	NNB-2/16Z	99086	May 14, 2002
3.	EMI Receiver	Rohde & Schwarz	ESI 7	830154/001	June 27, 2002
4.	50Ω Terminator	Amphenol	46650-51	N/A	Dec. 10, 2001
5.	RF Cable	Belden	M17/158	MIL-C-17	Jan. 20, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 2.2 Test Set-Up



### 2.3 Limit

Frequency	Limit (dBμV)			
	Class A		Class B	
MHz	Quasi Peak	Average	Quasi Peak	Average
0.15 ~ 0.50	79	66	66 ~ 56	56 ~ 46
0.50 ~ 5.0	73	60	56	46
5.0 ~ 30.0	73	60	60	50

Remark: In the above table, the tighter limit applies at the band edges.

## 2.4 Test Procedure

The EUT and simulators are connected to the main power through a line impedance stabilization network (LISN). It provides a 50 ohm / 50  $\mu$ H coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50 ohm / 50  $\mu$ H coupling impedance with 50 ohm termination. (Please refers to the block diagram of the test setup and photograph.)

Both sides of AC line are checked for the maximum conducted emission interference. In order to find the maximum emissions, the relating positions of equipment and all of the interference cables must be changed according to EN 55022/1998 regulation: The measurement procedure on conducted emission interference.

The resolution bandwidth of the field strength meter ( Rohde & Schwarz ) is set at 9KHz.

## 2.5 Test Specification

According to the EN 55022/1998

## 2.6 Test Result

The emissions that come from the EUT were below the specified limits. The worst case of conducted emissions measurement are shown in the appendix A. The acceptance criterion was met and the EUT has pass the measurement.

## 2.7 Deviation from the Test Method

No Deviation.

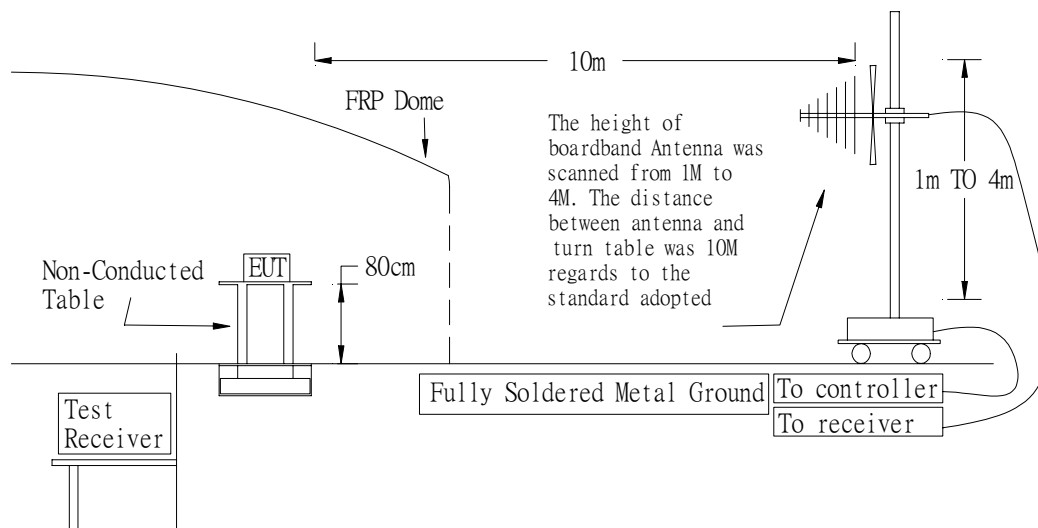
### 3. Radiated Emission Measurement

#### 3.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	Antenna	Mess-Elektronik	VULB 9160	9160-3078	Jan. 19, 2002
2.	EMI Receiver	Rohde & Schwarz	ESI 7	830154/001	June 22, 2002
3.	RF Cable	Adventest	AD-N-CA-01	2000-0220	Jan. 20, 2002
4.	OATS	Bestlab	N/A	OATS#1	May 28, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

#### 3.2 Test Setup





### 3.3 Limit

Frequency MHz	Class A		Class B	
	Distance (Meter)	Limit (dB $\mu$ V)	Distance (Meter)	Limit (dB $\mu$ V)
30 ~ 230	10	40	10	30
230 ~ 1000	10	47	10	37

Remark: In the above table, the tighter limit applies at the band edges

### 3.4 Test Procedure

The EUT and its simulators are placed on turn table, non-ducted and wooden, which is 0.8 meter above ground. The turn table rotates 360 degree to determine the position of the maximum emission level. The EUT was positioned such that distance from antenna to the EUT is 10 meters.

The antenna is moved up and down between 1 meter to 4 meter to receive the maximum emission level.

Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interference cables must be manipulated according to EN 55022/1998 regulation: the test procedure of the radiated emission measurement.

The bandwidth set on the field strength is 120KHz when the frequency range is below 1GHz

### 3.5 Test Specification

According to EN 55022/1998

### 3.6 Test Result

The emissions that come from the EUT was below the specified limits. The worst case of radiated emissions measurement are shown in the appendix A. The acceptance criterion was met and the EUT has pass the measurement.

### 3.7 Deviation from the Test Method

No Deviation.

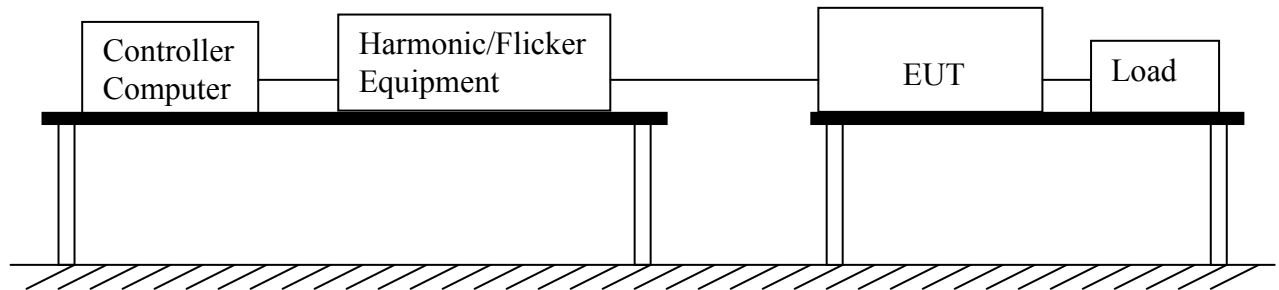
## 4. Power Harmonic and Voltage Fluctuation Measurement

### 4.1 Power Harmonic and Voltage Fluctuation Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	H/F Test System	EMC Partner	Harmonic-1000	325807	May. 10, 2002

Remark: All equipment upon which need to calibrated are with calibration period of 1 year.

### 4.2 Test Setup



### 4.3 Limit of Harmonic Current

Limit of Harmonic Currents

Harmonic Order	Maximum Permissible Harmonic Current (Ampere)	Harmonic Order	Maximum Permissible Harmonic Current (Ampere)
Odd Harmonic		Even Harmonic	
3	2.30	2	1.08
5	1.14	4	0.43
7	0.77	6	0.30
9	0.40	$8 \leq n \leq 40$	$0.23 \times 8/n$
11	0.33		
13	0.21		
$15 \leq n \leq 39$	$0.15 \times 15/n$		

## **4.4 Test Procedure**

The EUT is supplied in series with power analyzer from a power source has the same normal voltage and frequency as the rated supply voltage and the equipment under test. The rated voltage at the supply voltage of EUT of 0.94 times and 1.06 times shall be performed.

## **4.5 Test Specification**

According to EN 61000-3-2/2000, EN 61000-3-3/1995

## **4.6 Test Result**

The measurement of the power harmonics, which test at the extremes of EUT's supply range, was investigated and the test result was shown on the Appendix A. The acceptance criterion was met and the EUT has pass the measurement.

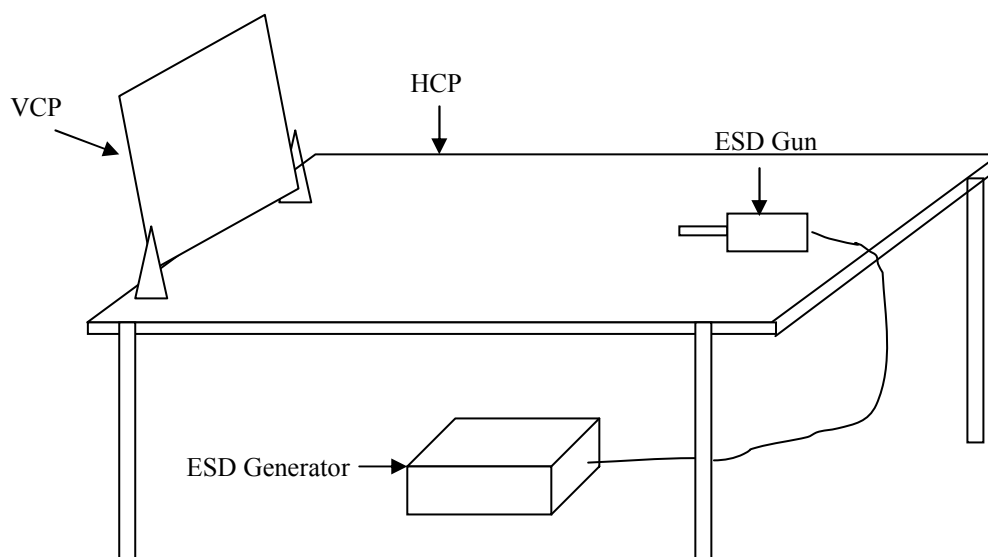
## 5. Electrostatic Discharge (ESD)

### 5.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	ESD Emulator	Noiseken	ESS-100L	0199C02380	Mar. 02, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 5.2 Test Setup



### 5.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Enclosure Room	Electrostatic Discharge	KV(Charge Voltage)	8 (Air Discharge) 4 (Contact Discharge)	B

## 5.4 Test Procedure

Direct applicant of discharge to the EUT:

Contact discharge was applied only to the conducted surfaces of the EUT.

Air discharge was applied only to the non-conductive surfaces of the EUT.

When the measurement was taken, The ESD discharger was performed in single discharge. For the single discharge time between successive single discharges will keep on one second. It was at least ten single discharges with positive and negative at the same selected pointed. The selected pointed, which was performed with electrostatic discharge, was marked on the red label on the EUT.

Indirect applicant of discharge to the EUT:

Vertical Coupling Plane (VCP)

The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the discharge electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten single discharges with positive and negative at the same selected point.

Horizontal Coupling Plane (HCP)

The coupling plane is placed under the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the discharge electrode touching the coupling.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten single discharges with positive and negative at the same selected pointed.

## 5.5 Test Specification

According to EN 61000-4-2/1998

## 5.6 Test Result

The measurement of the electrostatic discharge was investigated and the test result was shown on the Appendix A. The acceptance criterion was met and the EUT has passed the measurement.



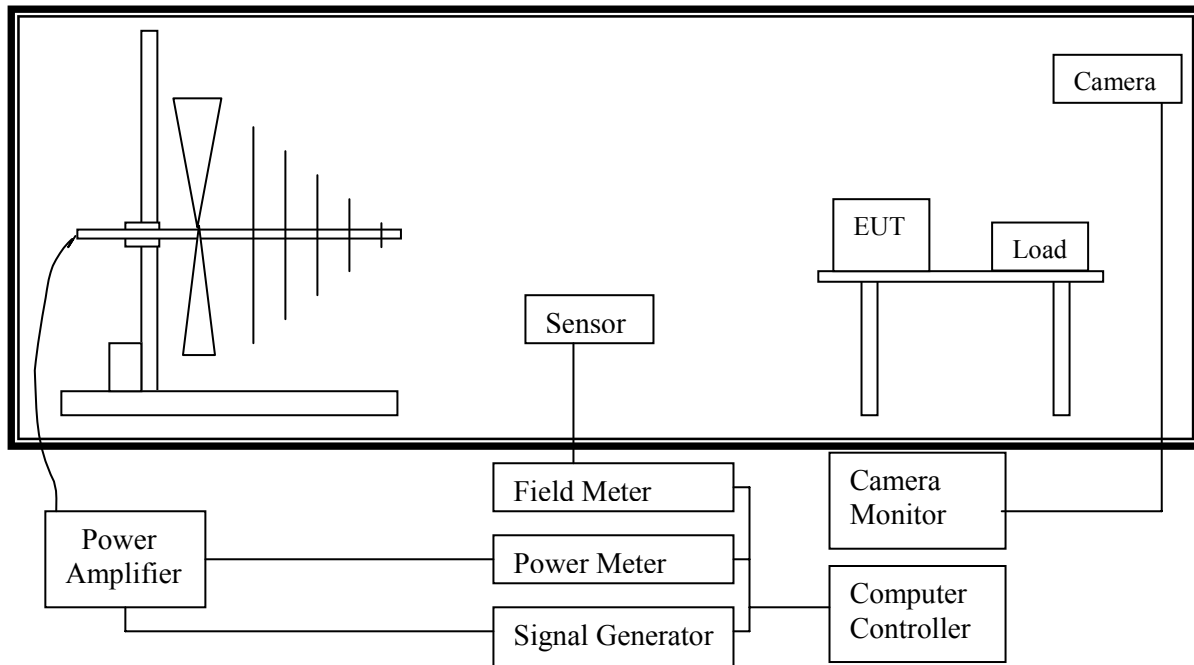
## 6. Radiated Susceptibility (RS)

### 6.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	Signal Generator	Rohde & Schwarz	SMY 02	845069/018	May 02, 2002
2.	Amplifier	Amplifier Research	100W1000M1A	20638	May 01, 2002
3.	Field Monitor	Amplifier Research	FM 2000	20391	Mar 03, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one and half year.

### 6.2 Test Setup



### 6.2 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Enclosure Room				
	Radio –Frequency	MHz	80 ~ 1000	A
	Electromagnetic Field	V/m (unmodulated, rms)	3	
	Amplitude Modulated	%AM (1KHz)	80	

### 6.3 Test Procedure

The EUT and load, which are placed on a wooden table that the height is 0.8 meter above ground, are placed with one coincident with the calibration plane such that the distance from antenna to the EUT is 3 meters.

Both horizontal and vertical polarization of the antenna position and four sides of the EUT are set on measurement.

In order to judge the EUT performance, a CCD camera is used to monitor the situation of EUT. All the scanning conditions are as follows:

Condition of Test	Remarks
EN 61000-4-3/1998	
1. Field Strength	3V/M; Level 2
2. Radiated Signal	AM 80% modulated with 1KHz
3. Scanning Frequencies	80MHz ~ 1000MHz
4. Dwell Time	3 seconds
5. Frequency step size $\Delta f$	1%
6. The rate of swept of frequency	$1.5 \times 10^{-3}$ decades/s

### 6.4 Specification

According to EN 61000-4-3/1998

### 6.5 Test Result

The measurement of the radiated susceptibility was investigated and the test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the measurement.

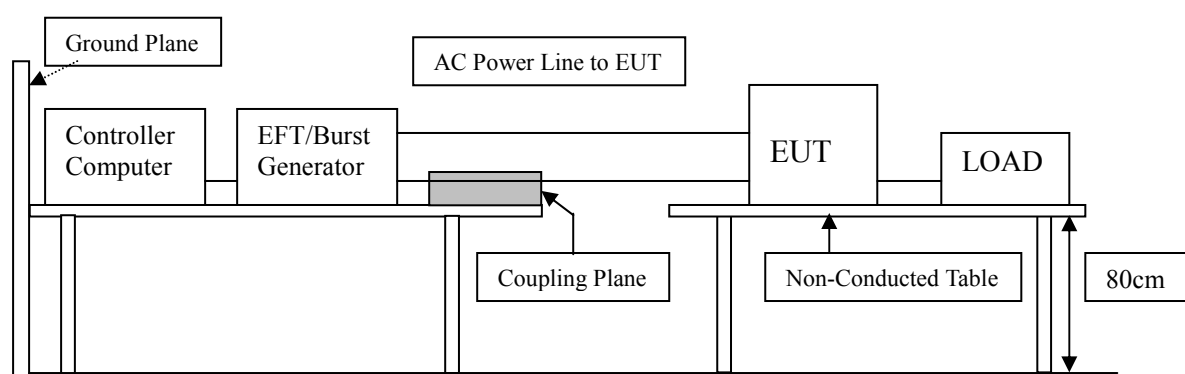
## 7 Electrical Fast Transient/Burst (EFT/B)

### 7.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	EMC Test System	EMC Partner	Transient-1000	TR1000-341	Aug 15, 2002
2.	Absorbing Clamp	EMC Partner	Transient-1000	CNEFT1000-176	Aug 15, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 7.2 Test Setup



### 7.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Ports for signal Lines and Control Lines				B
Fast Transients Common Mode		KV (Peak)	0.5	
		Tr/Ts (ns)	5/50	
		Rep. Frequency (KHz)	5	
DC Input and DC Output Power Ports				B
Fast Transients Common Mode		KV (Peak)	0.5	
		Tr/Ts (ns)	5/50	
		Rep. Frequency (KHz)	5	
Input and Output AC Power Ports				B
Fast Transients Common Mode		KV (Peak)	1	
		Tr/Ts (ns)	5/50	
		Rep. Frequency (KHz)	5	
Functional Earth Ports				B
Fast Transients Common Mode		KV (Peak)	0.5	
		Tr/Ts (ns)	5/50	
		Rep. Frequency (KHz)	5	

## 7.4 Test Procedure

The EUT and load are placed on a wooden table that is 0.8meter height above a metal ground plane dimension is 1m x 1m and thickness is at least 0.2mm. It also projected beyond the EUT by at lease 0.1meter on all sides.

For Input and Output AC power or DC Input and DC Output Power Ports:

The EUT is connected with the power mains through a coupling device that directly couples the EFT interference signal.

Each of the line and nature conductors is impressed with burst noise for 1 minute.

For Functional Earth Port:

The EUT is connected to the power mains through a coupling device that directly couples the EFT interference signal.

The protective earth line (PE) is impressed with burst noise for 1 minute.

The length of power cord between the coupling device and the EUT shall be 1 meter.

For signal Lines and Control Lines Test:

The EFT interference signal is through a coupling clamp device couples to the signal and control lines of the EUT with burst noise for 1 minute.

## 7.5 Test Specification

According to EN 61000-4-4/1995

## 7.6 Test Result

The measurement of the Electrical Fast Transient/Burst was investigated and test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the measurement.

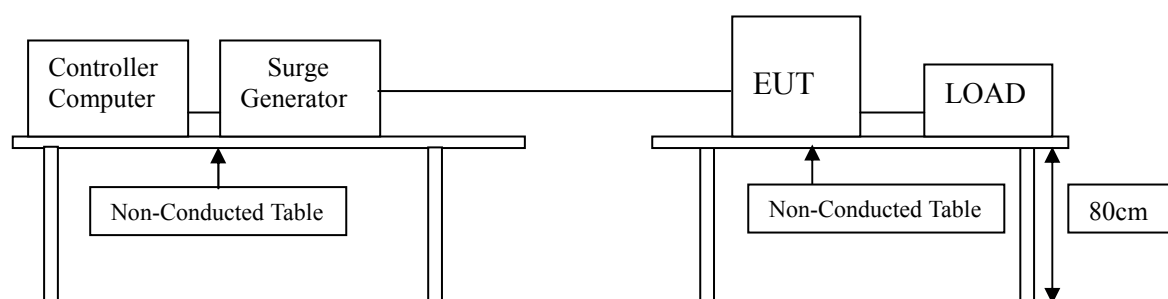
## 8. Surge

### 8.1 Test Equipment List

No	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	EMC Test System	EMC Partner	Transient-1000	TR1000-341	Aug 15, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 8.2 Test Setup



### 8.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Dc Input and DC Output Power Ports				
	Surge	Tr/Ts ( $\mu$ s)	1.2/50(8/20)	B
	Line to Ground	KV	$\pm 0.5$	
	Line to Line	KV	$\pm 0.5$	
AC Input and Ac Output Power Ports				
	Surge	Tr/Ts ( $\mu$ s)	1.2/50(8/20)	B
	Line to Ground	KV	$\pm 2$	
	Line to Line	KV	$\pm 1$	



## 8.4 Test Procedure

The EUT and its load are placed on a table which is 0.8 meter height above a metal ground plane dimension is 1 meter x 1 meter and the thickness is 0.5 mm. It's also projected beyond the EUT at least 0.1 meter on all sides. The length of power cord between the coupling device and the EUT shall be 2meter or less.

For Input and Output AC Power or DC Input and Dc Output Power Ports:

The EUT is connected to the power mains through a coupling device that directly couples the Surge interference signal.

The Surge noise shall be applied synchronized to the voltage phase at 0°, 90°, 180°, 270° and the peak value of the AC voltage wave. (Positive and Negative)

Each of line-earth and line-line is impressed with a sequence of five surge voltages with interval of 1 minute.

## 8.5 Test Specification

According to EN 61000-4-5/1995

## 8.6 Test Result

The Measurement of the Surge was investigated and the test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the test.

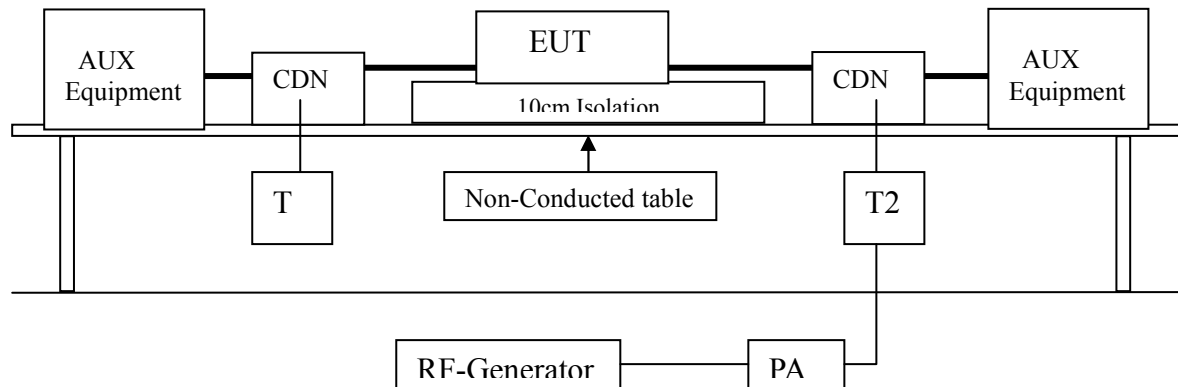
## 9. Conducted Susceptibility

### 9.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	Signal Generator	Rohde & Schwarz	SMY 02	845069/018	May 02, 2002
2.	Power Amplifier	Amplifier Research	100W1000M1A	20638	May 01, 2002
4.	Directional Coupler	Amplifier Research	DC2600	20508	Aug 23, 2002
5.	CDN	FCC	FCC-801-M3-25A	9993	Aug 23, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 9.2 Test Setup



### 9.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Ports for Signal Lines and Data Buses, not involved in process control, etc.				
	Radio-Frequency	MHz	0.15 ~ 80	A
	Common Mode	V (rms, Unmodulated)	3	
	Amplitude Modulated	%AM (1KHz)	80	
		Source Impedance	150	
Ac Input and AC Output and DC Input and DC output Ports and Functional Earth Ports				
	Radio-Frequency	MHz	0.15 ~ 80	A
	Common Mode	V (rms, Unmodulated)	3	
	Amplitude Modulated	%AM (1KHz)	80	
		Source Impedance	150	

## 9.4 Test Procedure

The EUT are placed on a table which is 0.8meter height and a ground reference plane on the table, the EUT are placed upon table and use a 10cm insulation between the EUT and ground reference plane.

For AC Input and AC Output Power or DC Input and DC Output Power Ports:  
The EUT is connected to the power mains through a coupling and decoupling networks for power supply lines. It also directly couples the disturbance signal into EUT.  
Use CDN-M2 for two wires or CDN-3 for three wires.

For Signal Lines and Control Lines Test:  
The disturbance signal is through a coupling and decoupling networks (CDN) or EM-clamp device couples to the signal and control lines of the EUT.

All scanning frequencies conditions are as following:

Condition of Test	Remarks:
1. Field Strength	130dB $\mu$ V (3V), Level 2
2. Radiated Signal	AM 80% modulated with 1KHz
3. Scanning frequencies	0.15MHz ~ 80MHz
4. Dwell Time	3 seconds
5. Frequency step size $\Delta f$	1%
6. The rate of Swept of Frequency	$1.5 \times 10^{-3}$ decades/s

## 9.5 Test Specification

According to EN 61000-4-6/1996

## 9.6 Test Result

The Measurement of the Conducted Susceptibility was investigated and the test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the test.

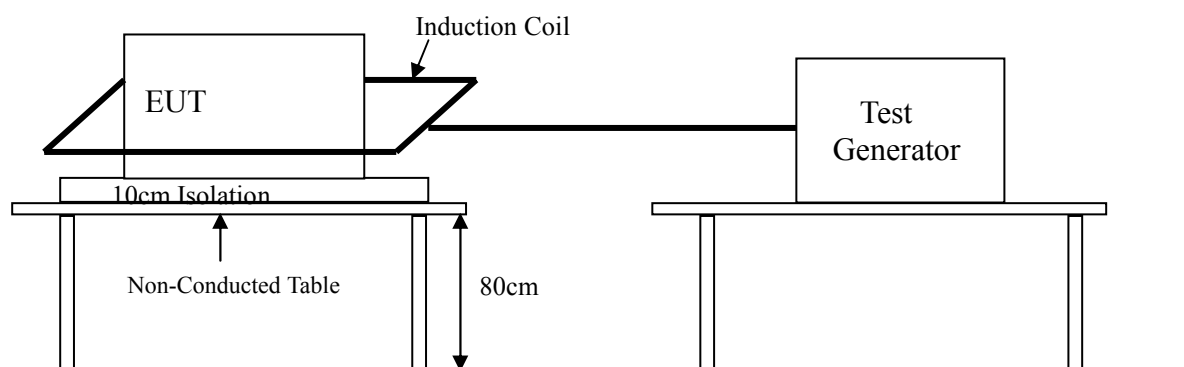
## 10 Power Frequency Magnetic Field

### 10.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	EMC Test System	EMC Partner	Transient-1000	TR1000-341	Aug 15, 2002
2.	Magnetic Coil	EMC Partner	MF-1000	MF1000-1-51	Aug 15, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 10.2 Test Setup



### 10.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Enclosure Room				
Power-Frequency		50	Hz	A
Magnetic Field		1	A/M	

## **10.4 Test Procedure**

The EUT and its load are placed on a table that is 0.8 meter above the metal ground plane dimension is at least 1 meter x 1 meter. The test magnetic field shall be placed at least than 3 meters distance from the induction coil.

The test magnetic field shall be applied by the immersion method to the EUT. The induction coil shall be rotated by 90° in order to expose the EUT to the test field with different orientation (X, Y, Z orientation).

## **10.5 Test Specification**

According to EN 61000-4-8/1993

## **10.6 Test Result**

The Measurement of the Power Frequency Magnetic Field was investigated and the test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the test.



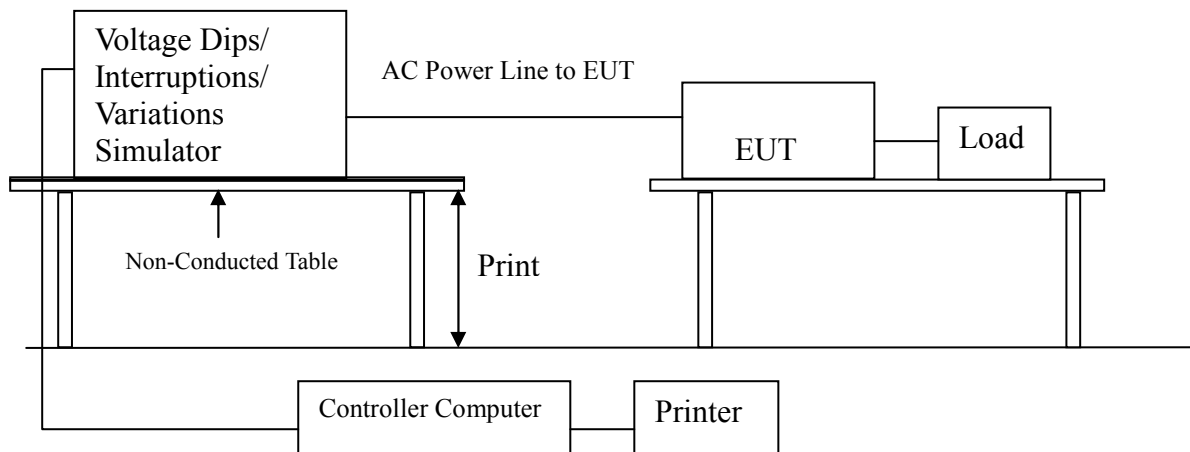
## 11. Voltage Dips and Interruption Measurement

### 11.1 Test Equipment List

No.	Instrument	Manufacture	Model	Serial No.	Last Calibrate
1.	EMC Test System	EMC Partner	Transient-1000	TR1000-341	Aug 15, 2002

Remark: All equipment upon which need to calibrated are with calibration period of one year.

### 11.2 Test setup



### 11.3 Test Level

Item	Environment	Unit	Test Specification	Performance Criteria
Ac Input and AC Output Power Ports	Voltage Dips		30% Reduction	B
			500ms	
	Voltage Interruption		>95% Reduction	C
			10ms	
			>95% Reduction	C
			5000ms	

## 11.4 Test Procedure

The EUT and its load are placed on a wooden table which is 0.8 meter above a metal ground plane which dimension is 1 meter x 1 meter, the thickness is 0.65mm. It projected beyond the EUT by at least 0.1 meter on all sides. The power cord shall be used the shortest power cord as specified by the manufacturer.

For Voltage Dips / Interruption Test:

The EUT is connected to the power mains through a coupling device that directly couples to the Voltage Dips and Interruption Generator.

The EUT shall be tested for 30% voltage dips of supplied voltage and duration time is 500ms, for 95% voltage dips of supplied voltage and duration time is 500ms with a sequence of three voltage dips with intervals of 10 seconds, and for 95% voltage interruption of supplied voltage and the duration time is 5000ms with a sequence of three voltage interruptions with intervals of 10 seconds.

Voltage phase shifting are shall occur at 0°, 45°, 90°, 135°, 180°, 225°, 270°, 315° of the voltage.

## 11.5 Test Specification

According to EN 61000-4-11/1994

## 11.6 Test Result

The Measurement of the Voltage Dips and Interruption was investigated and the test result was shown on the appendix A. The acceptance criterion was met and the EUT has passed the test.

## **12 Modification List for EMC Complying Test**

The modification is solely made by the applicant

## **13 Appendix**

Appendix A: Summary of Test Result

Appendix B: The test photograph of EUT

Appendix C: The Detail Photograph of EUT

## Appendix A: Summary of Test Result

The test result in the emission and immunity were performed according to the requirement of measurement standard and procedures. Best Laboratory is assumed full responsibility for the accuracy and completeness of these measurements. The Test data of the emissions and immunity are listed as the appendix data.

All these tests are were carried out with the EUT in normal operation, which was defined as:

**\*\*\*\*\* EMC Test Result: The EUT has been passed the all measurements. \*\*\*\*\***

The uncertainty is calculated in accordance with NAMAS NIS 81, the total uncertainty for this test is as follows:

⇒ Emission Test

- |  |         |
|--|---------|
| * Uncertainty in the Conducted Emission Test:    | <±2.0dB |
| * Uncertainty in the Field Strength measurement: | <±4.0dB |

## Conducted Emission Test

Date Measurement Performed: Oct. 25, 2002

EUT : Half size CPU card support PIII level CPU W/LAN, USB x 2, COM x 2, VGA, LPT, PS/2 Keyboard & Mouse

Testing Mode : 800 X 600/ LAN=10MHz

Temperature : 24°C

Humidity : 57%RH

### Line 1:

Frequency (KHz)	Corrected Amplitude (dBμV)			Limit (dBμV)		Margin dB
	Peak	QP	Avg.	QP	Avg.	
168.7000	57.52	57.30	51.42	65.47	55.47	-4.05
199.3000	59.27	58.04	50.91	64.39	54.59	-3.68
310.6500	53.65	53.56	51.17	61.41	51.41	-0.24
423.7000	50.68	54.47	47.68	58.18	48.18	-0.50
534.2000	49.55	49.01	45.45	56.00	46.00	-0.55
647.2500	49.42	48.63	45.58	56.00	46.00	-0.42
701.6500	45.83	45.32	43.83	56.00	46.00	-2.17
758.6000	48.23	47.74	43.77	56.00	46.00	-2.23
869.9500	49.17	48.89	42.83	56.00	46.00	-3.17
981.3000	47.71	47.13	40.29	56.00	46.00	-5.71

### Line 2:

Frequency (KHz)	Corrected Amplitude (dBμV)			Limit (dBμV)		Margin dB
	Peak	QP	Avg.	QP	Avg.	
169.5500	57.24	56.63	49.64	65.44	55.44	-5.80
196.7500	58.82	58.22	51.50	64.66	54.66	-3.16
308.9500	52.97	52.41	49.95	61.45	51.46	-1.51
422.0000	49.45	48.93	48.01	58.23	48.23	-0.22
535.0500	49.70	49.29	45.30	56.00	46.00	-0.70
646.4000	49.51	49.00	45.49	56.00	46.00	-0.51
758.6000	49.38	48.77	43.82	56.00	46.00	-2.18
871.6500	48.39	47.87	43.61	56.00	46.00	-2.39
983.0000	46.86	46.41	45.14	56.00	46.00	-0.86
1095.0000	46.01	45.58	39.99	56.00	46.00	-6.01

\*\*\* Remark: The above corrected amplitudes are all under the average limit. \*\*\*

## Conducted Emission Test

Date Measurement Performed: Oct. 25, 2002

EUT : Half size CPU card support PIII level CPU W/LAN, USB x 2, COM x 2, VGA, LPT, PS/2 Keyboard & Mouse

Testing Mode : 800 X 600/ LAN=100MHz

Temperature : 24°C

Humidity : 57%RH

### Line 1:

Frequency (KHz)	Corrected Amplitude (dBμV)			Limit (dBμV)		Margin dB
	Peak	QP	Avg.	QP	Avg.	
171.250	56.99	56.18	48.82	65.39	55.39	-6.58
197.600	59.04	58.09	52.49	64.64	54.64	-2.15
311.500	55.73	55.08	50.95	61.39	51.39	-0.44
422.850	51.06	50.38	47.79	58.20	48.20	-0.41
534.200	50.72	49.09	45.82	56.00	46.00	-0.18
647.250	49.72	48.63	45.22	56.00	46.00	-0.78
758.600	47.64	47.00	43.29	56.00	46.00	-2.71
871.650	47.75	46.51	42.32	56.00	46.00	-3.68
983.850	46.21	45.14	40.54	56.00	46.00	-5.46
1095.000	46.46	44.37	39.88	56.00	46.00	-6.12

### Line 2:

Frequency (KHz)	Corrected Amplitude (dBμV)			Limit (dBμV)		Margin dB
	Peak	QP	Avg.	QP	Avg.	
169.550	56.48	55.76	49.66	65.44	55.44	-5.78
200.150	60.18	57.04	51.55	64.57	54.57	-3.01
310.650	55.24	53.79	50.18	61.41	51.41	-1.23
422.000	50.67	49.74	47.96	58.23	48.23	-0.27
534.200	49.29	48.82	45.57	56.00	46.00	-0.43
648.950	49.72	49.08	45.55	56.00	46.00	-0.45
760.300	48.63	47.99	43.63	56.00	46.00	-2.37
872.500	48.74	47.05	42.30	56.00	46.00	-3.70
983.850	45.66	44.98	40.48	56.00	46.00	-0.34
1095.000	46.11	45.13	40.24	56.00	46.00	-5.76

\*\*\* Remark: The above corrected amplitudes are all under the average limit. \*\*\*

## Field Strength Test

Date Measurement Performed: Oct. 24, 2002

EUT : Half size CPU card support PIII level CPU W/LAN, USB x 2, COM x 2, VGA, LPT, PS/2 Keyboard & Mouse  
 Testing Mode : 800 X 600/ LAN=100MHz  
 Polarity : Vertical  
 Temperature : 25°C  
 Humidity : 71%RH

Frequency (MHz)	Reading Amplitude (dBμV/m)	Table Degree (°)	Antenna Height (Meter)	Correction Factor (dB/m)	Corrected Amplitude (dBμV/m)	Limit (dBμV/m)	Margin (dB)
47.801	12.30	40	1.00	9.04	21.34	30.00	-8.66
79.990	11.03	361	1.00	8.34	19.37	30.00	-10.63
133.656	16.38	5	1.00	12.23	28.61	30.00	-1.39
152.174	16.10	110	1.00	11.22	27.32	30.00	-2.68
624.117	10.42	314	1.00	20.89	31.31	37.00	-5.69
***							

Remark:

1. The “ Correction Factor “ contains antenna factor, cable loss.
2. The formula of “ Corrected Amplitude “ is as follow”  
 Reading Amplitude + Correction Factor = Corrected Amplitude.



## Field Strength Measurement

Date Measurement Performed: Oct. 24, 2002

EUT : Half size CPU card support PIII level CPU W/LAN, USB x 2, COM x 2, VGA, LPT, PS/2 Keyboard & Mouse  
 Testing Mode : 800 X 600/ LAN=100MHz  
 Polarity : Horizontal  
 Temperature : 23°C  
 Humidity : 78%RH

Frequency (MHz)	Reading Amplitude (dBμV/m)	Table Degree (°)	Antenna Height (Meter)	Correction Factor (dB/m)	Corrected Amplitude (dBμV/m)	Limit (dBμV/m)	Margin (dB)
71.250	17.72	78	4.00	7.09	24.80	30.00	-5.20
111.860	2.97	182	3.00	12.34	15.31	30.00	-14.69
624.145	11.47	18	4.00	20.89	32.36	37.00	-4.64
720.194	4.08	135	2.00	20.83	24.91	37.00	-12.09
***							

Remark:

1. The “ Correction Factor “ contains antenna factor, cable loss.
2. The formula of “ Corrected Amplitude “ is as follow”  
 Reading Amplitude + Correction Factor = Corrected Amplitude.

## Power Harmonic / Fluctuation Test

### Power Harmonic:

Operating Environment:

Temperature : 26°C  
Humidity : 68%RH  
Atmosphere : 1010mBar

Test Condition:

EUT Position : Table Top

Result:

Summary of the test result: Pass

### Fluctuation Test:

Test Frequency	: 50Hz	Test Voltage	: 230VAC
Test Time	: 10 min.	Tshort	: 5.0 min

EUT	Data	Limit	Result	Test Enable
Pst	0.001	1.00	Pass	True
Plt	0.001	0.65	Pass	True
dc %	0.00	3.00	Pass	True
dmax %	0.00	4.00	Pass	True
d(t) sec	0.00	0.20	Pass	True

#### Power Source Data

Source Pst max	0.022	0.400	Pass	True
% THD	0.02	3.00	Pass	True

## Electrostatic Discharge Test

Item	Amount of Discharge	Voltage	Required Criteria	Complied to Criteria	Results
Air Discharge	10	+2KV	B	B	Pass
	10	-2KV	B	B	Pass
	10	+4KV	B	B	Pass
	10	-4KV	B	B	Pass
	10	+8KV	B	B	Pass
	10	-8KV	B	B	Pass
Contact Discharge	25	+2KV	B	B	Pass
	25	-2KV	B	B	Pass
	25	+4KV	B	B	Pass
	25	-4KV	B	B	Pass
Indirect Discharge	25	+2KV	B	B	Pass
	25	-2KV	B	B	Pass
	25	+4KV	B	B	Pass
	25	-4KV	B	B	Pass

Remark:

- ☐ Criteria A: Operation as intended during and after the measurement
- ☒ Criteria B: Operation as Intended after the test
- ☐ Criteria C: Malfunction during and after, need manual reset
- ☐ Criteria D: The sample is damaged

## Radiated Susceptibility

Frequency (MHz)	Position (Angle)	Polarity (H or V)	Voltage (V/m)	Required Criteria	Complied Criteria	Result
80 ~ 1000	0	H	3	A	A	Pass
80 ~ 1000	0	V	3	A	A	Pass
80 ~ 1000	90	H	3	A	A	Pass
80 ~ 1000	90	V	3	A	A	Pass
80 ~ 1000	180	H	3	A	A	Pass
80 ~ 1000	180	V	3	A	A	Pass
80 ~ 1000	270	H	3	A	A	Pass
80 ~ 1000	270	V	3	A	A	Pass

### Remark:

- ☒ Criteria A: Operation as intended during and after the measurement
- ☐ Criteria B: Operation as Intended after the test
- ☐ Criteria C: Malfunction during and after, need manual reset
- ☐ Criteria D: The sample is damaged

**Electrical Fast Transient / Burst**

Inject Line	Polarity	Voltage (KV)	Inject Time (Second)	Inject Method	Required Criteria	Complied Criteria	Result
L	±	1.0KV	60	Direct	B	B	Pass
N	±	1.0KV	60	Direct	B	B	Pass
PE	±	1.0KV	60	Direct	B	B	Pass
L+N	±	1.0KV	60	Direct	B	B	Pass
L+PE	±	1.0KV	60	Direct	B	B	Pass
N+PE	±	1.0KV	60	Direct	B	B	Pass
L+N+PE	±	1.0KV	60	Direct	B	B	Pass
Clamp	±	0.5KV	60	Couple	B	B	Pass

## Remark:

- ☐ Criteria A: Operation as intended during and after the measurement  
☒ Criteria B: Operation as Intended after the test  
☐ Criteria C: Malfunction during and after, need manual reset  
☐ Criteria D: The sample is damaged

## Surge Test

Inject Line	Polarity	Angle	Voltage (KV)	Inject Time (Second)	Inject Method	Required Criteria	Complied Criteria	Result
L+N	±	0	0.5KV	60	Direct	B	B	Pass
L+N	±	90	0.5KV	60	Direct	B	B	Pass
L+N	±	180	0.5KV	60	Direct	B	B	Pass
L+N	±	270	0.5KV	60	Direct	B	B	Pass
L+N	±	0	1.0KV	60	Direct	B	B	Pass
L+N	±	90	1.0KV	60	Direct	B	B	Pass
L+N	±	180	1.0KV	60	Direct	B	B	Pass
L+N	±	270	1.0KV	60	Direct	B	B	Pass
L+PE	±	0	0.5KV	60	Direct	B	B	Pass
L+PE	±	90	0.5KV	60	Direct	B	B	Pass
L+PE	±	180	0.5KV	60	Direct	B	B	Pass
L+PE	±	270	0.5KV	60	Direct	B	B	Pass
L+PE	±	0	1.0KV	60	Direct	B	B	Pass
L+PE	±	90	1.0KV	60	Direct	B	B	Pass
L+PE	±	180	1.0KV	60	Direct	B	B	Pass
L+PE	±	270	1.0KV	60	Direct	B	B	Pass
L+PE	±	0	2.0KV	60	Direct	B	B	Pass
L+PE	±	90	2.0KV	60	Direct	B	B	Pass
L+PE	±	180	2.0KV	60	Direct	B	B	Pass
L+PE	±	270	2.0KV	60	Direct	B	B	Pass
N+PE	±	0	0.5KV	60	Direct	B	B	Pass
N+PE	±	90	0.5KV	60	Direct	B	B	Pass
N+PE	±	180	0.5KV	60	Direct	B	B	Pass
N+PE	±	270	0.5KV	60	Direct	B	B	Pass
N+PE	±	0	1.0KV	60	Direct	B	B	Pass
N+PE	±	90	1.0KV	60	Direct	B	B	Pass
N+PE	±	180	1.0KV	60	Direct	B	B	Pass
N+PE	±	270	1.0KV	60	Direct	B	B	Pass
N+PE	±	0	2.0KV	60	Direct	B	B	Pass
N+PE	±	90	2.0KV	60	Direct	B	B	Pass
N+PE	±	180	2.0KV	60	Direct	B	B	Pass
N+PE	±	270	2.0KV	60	Direct	B	B	Pass

Remark:

- ☐ Criteria A: Operation as intended during and after the measurement
- ☒ Criteria B: Operation as Intended after the test
- ☐ Criteria C: Malfunction during and after, need manual reset
- ☐ Criteria D: The sample is damaged

## Conducted Susceptibility

Inject Line	Field Strength dB $\mu$ V (V)	Inject Method	Required Criteria	Complied Criteria	Result
AC Line	130(3V)	CDN	A	A	Pass
Data Cable	130(3V)	CDN	A	A	Pass

### Remark:

- ☒ Criteria A: Operation as intended during and after the measurement
- ☐ Criteria B: Operation as Intended after the test
- ☐ Criteria C: Malfunction during and after, need manual reset
- ☐ Criteria D: The sample is damaged

## Power Frequency Magnetic Field Test

Polarization	Frequency (Hz)	Magnetic Strength (A/M)	Required Criteria	Complied Criteria	Result
X Orientation	50	1	A	A	Pass
Y Orientation	50	1	A	A	Pass
Z Orientation	50	1	A	A	Pass

### Remark:

- ☒ ( X ) Criteria A: Operation as intended during and after the measurement
- ☐ ( ) Criteria B: Operation as Intended after the test
- ☐ ( ) Criteria C: Malfunction during and after, need manual reset
- ☐ ( ) Criteria D: The sample is damaged



## Voltage Dips and Interruption Test

Voltage Dips and Interruption Reduction (%)	Angle (Degree)	Test Duration (ms)	Required Criteria	Complied Criteria	Result
DIP					
30	0	500	B	B	Pass
30	45	500	B	B	Pass
30	90	500	B	B	Pass
30	135	500	B	B	Pass
30	180	500	B	B	Pass
30	225	500	B	B	Pass
30	270	500	B	B	Pass
30	315	500	B	B	Pass
>95	0	10	C	C	Pass
>95	45	10	C	C	Pass
>95	90	10	C	C	Pass
>95	135	10	C	C	Pass
>95	180	10	C	C	Pass
>95	225	10	C	C	Pass
>95	270	10	C	C	Pass
>95	315	10	C	C	Pass
Interruption					
>95	0	5000	C	C	Pass
>95	45	5000	C	C	Pass
>95	90	5000	C	C	Pass
>95	135	5000	C	C	Pass
>95	180	5000	C	C	Pass
>95	225	5000	C	C	Pass
>95	270	5000	C	C	Pass
>95	315	5000	C	C	Pass

Remark:

- ☐ Criteria A: Operation as intended during and after the measurement
- ☒ Criteria B: Operation as Intended after the test (Test Mode: 30%)
- ☒ Criteria C: Malfunction during and after, need manual reset(Test Mode: 60%, >95%)
- ☐ Criteria D: The sample is damaged

## **Appendix B: The Test Photograph of EUT**

## The Photograph of Conducted Emission Test --- Mains Port



## The Photograph of Radiated Emission Test



## The Photograph of Radiation Susceptibility Test





### The Photograph of Electrical Fast Transient/Burst Test



### The Photograph of Electrostatic Discharge Test



### The Photograph of Surge Test



### The Photograph of Conducted Susceptibility Test



### The Photograph of Power Frequency Magnetic Field Test



### The Photograph of Voltage Dips and Interruption Test





## **Appendix C: The Detail Photograph of EUT**



